

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of

Tomoko TAKAGI et al.

Serial No.: 10/726,300

Filed: December 1, 2003

New York, New York

Date: January 20, 2004

Group Art Unit: ---

Examiner: ---

For: THIN FILM DEPOSITING METHOD AND APPARATUS

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

SUBMISSION

Sir:

Submitted herewith is a copy of art together with a form listing the same for the

convenience of the Examiner.

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents P.O. Box 1450, Alexandria, VA 22313-1450, on January 20, 2004

Max Moskowitz

Name of applicant, assignee or Registered Representative

/Signature
January 20, 2004

Date of Signature

Respectfully submitted,

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MM:mjb Enclosures

		Application	10/726,300	OFGS File No	OFGS File No. P/2850-90			
APPLICASTS ART CITATION (Use several stress if necessary)			Applicant Tomoko TAKAGI et al.					
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Examiner		Date Con	Date Considered					
EXAMINER: Initial if citation not considered. Include copy	n considered, whethe	er or not citation in	s in conformance with MPEP § 609	; Draw line throu	gh citation if no	ot in conform	ance and	
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